

High-Speed Drivers with SPDT JFET Switches

Features

- Constant On-Resistance Over Entire Analog Range
- Low Leakage
- Low Crosstalk
- Rad Hardness

Benefits

- Low Distortion
- Eliminates Large Signal Errors
- High Precision
- High Bandwidth Capability
- Fault Protection

Applications

- Audio Switching
- Video Switching
- Sample/Hold
- Guidance and Control Systems
- Telemetry

Description

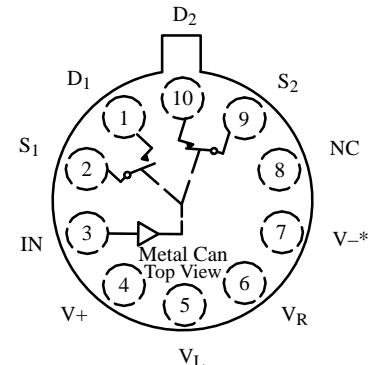
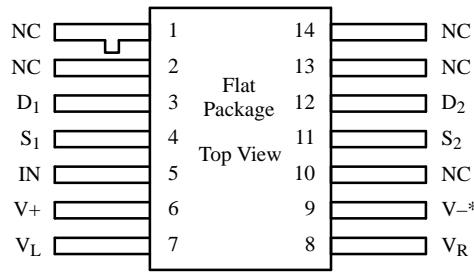
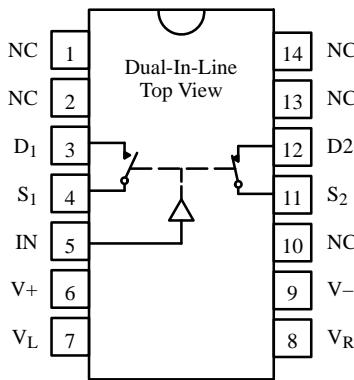
The DG186/187/188 are precision single-pole, double-throw (SPDT) analog switches designed to provide accurate switching of video and audio signals. This series is ideally suited for applications requiring a constant on-resistance over the entire analog range.

The major difference in the devices is the on-resistance (DG186— $10\ \Omega$, DG187— $30\ \Omega$, DG188— $75\ \Omega$). Reduced errors are achieved through low leakage current ($I_{D(on)} < 2\ nA$). Applications which benefit from the flat JFET

on-resistance include audio switching, video switching, and data acquisition.

To achieve fast and accurate switch performance, each device comprises two n-channel JFET transistors and a TTL compatible bipolar driver. The driver is designed to achieve break-before-make switching action, eliminating the inadvertent shorting between channels and the crosstalk which would result. In the on state, each switch conducts current equally well in either direction. In the off condition, the switches will block up to 20 V peak-to-peak, with feedthrough of less than $-60\ dB$ at 10 MHz.

Functional Block Diagram and Pin Configuration



*Common to Substrate and Case

Truth Table

Logic	SW ₁	SW ₂
0	OFF	ON
1	ON	OFF

Logic "0" $\leq 0.8\ V$
Logic "1" $\geq 2.0\ V$

Updates to this data sheet may be obtained via facsimile by calling Siliconix FaxBack, 1-408-970-5600. Please request FaxBack document #70033.

Ordering Information

Temp Range	Package	Part Number
-55 to 125°C	10-Pin Metal Can	DG186AA/883
		DG187AA/883, JM38510/11105BIA
		DG188AA/883, JM38510/11106BIA
	14-Pin Sidebrazed	DG186AP/883
		DG187AP/883, JM38510/11105BCA
		DG188AP
		DG188AP/883, JM38510/11106BCA
	14-Pin Flat Pack	JM38510/11105BXA
		JM38510/11106BXA

Absolute Maximum Ratings

V ₊ to V ₋	36 V	Current (S or D) DG187, DG188	30 mA
V ₊ to V _D	33 V	Current (All Other Pins)	30 mA
V _D to V ₋	33 V	Storage Temperature	-65 to 150°C
V _D to V _D	± 22 V	Power Dissipation ^a	
V _L to V ₋	36 V	10-Pin Metal Can ^b	450 mW
V _L to V _{IN}	8 V	14-Pin Sidebrazed ^c	825 mW
V _L to V _R	8 V	14-Pin Flat Pack ^d	900 mW
V _{IN} to V _R	8 V	Notes:	
V _R to V ₋	27 V	a. All leads welded or soldered to PC Board.	
V _R to V _{IN}	2 V	b. Derate 6 mW/°C above 75°C	
Current (S or D) DG186	200 mA	c. Derate 11 mW/°C above 75°C	
		d. Derate 10 mW/°C above 75°C	

Schematic Diagram (Typical Channel)

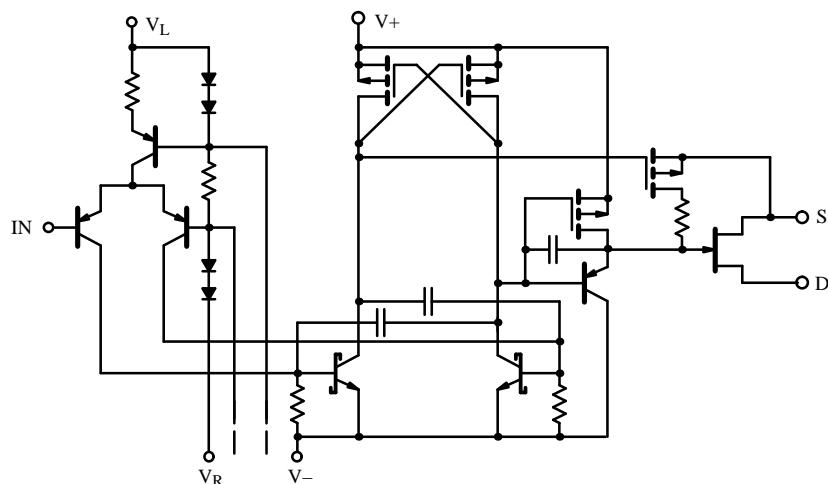


Figure 1.

Specifications^a for DG186

Parameter	Symbol	Test Conditions Unless Otherwise Specified $V_+ = 15 \text{ V}$, $V_- = -15 \text{ V}$, $V_L = 5 \text{ V}$ $V_R = 0 \text{ V}$, $V_{IN} = 0.8 \text{ or } 2 \text{ V}^f$	Temp ^b	Limits			Unit
				Min ^d	Typ ^c	Max ^d	
Analog Switch							
Analog Signal Range ^e	V_{ANALOG}		Full	-7.5		15	V
Drain-Source On-Resistance	$r_{DS(on)}$	$I_S = -10 \text{ mA}$, $V_D = -7.5 \text{ V}$	Room Full		7.5	10 20	Ω
Source Off Leakage Current	$I_{S(off)}$	$V_S = \pm 10 \text{ V}$, $V_D = \mp 10 \text{ V}$ $V_+ = 10 \text{ V}$, $V_- = -20 \text{ V}$	Room Hot		0.05	10 1000	nA
		$V_S = \pm 7.5 \text{ V}$, $V_D = \mp 7.5 \text{ V}$	Room Hot		0.05	10 1000	
Drain Off Leakage Current	$I_{D(off)}$	$V_S = \pm 10 \text{ V}$, $V_D = \mp 10 \text{ V}$ $V_+ = 10 \text{ V}$, $V_- = -20 \text{ V}$	Room Hot		0.04	10 1000	
		$V_S = \pm 7.5 \text{ V}$, $V_D = \mp 7.5 \text{ V}$	Room Hot		0.03	10 1000	
Channel On Leakage Current	$I_{D(on)}$	$V_D = V_S = \pm 7.5 \text{ V}$	Room Hot	-2 -200	-0.1		
Saturation Drain Current	I_{DSS}	2 ms Pulse Duration	Room		300		mA
Digital Input							
Input Current with Input Voltage High	I_{INH}	$V_{IN} = 5 \text{ V}$	Room Hot		<0.01	10 20	μA
Input Current with Input Voltage Low	I_{INL}	$V_{IN} = 0 \text{ V}$	Full	-250	-30		
Dynamic Characteristics							
Turn-On Time	t_{on}	See Switching Time Test Circuit	Room		240	400	ns
Turn-Off Time	t_{off}		Room		140	200	
Source-Off Capacitance	$C_{S(off)}$	$f = 1 \text{ MHz}$	$V_S = -5 \text{ V}$, $I_D = 0$	Room	21		pF
Drain-Off Capacitance	$C_{D(off)}$		$V_D = -5 \text{ V}$, $I_S = 0$	Room	17		
Channel-On Capacitance	$C_{D(on)}$		$V_D = V_S = 0 \text{ V}$	Room	17		
Off Isolation	OIRR	$f = 1 \text{ MHz}$, $R_L = 75 \Omega$		Room	>55		dB
Power Supplies							
Positive Supply Current	I_+	$V_{IN} = 0 \text{ V}$, or 5 V	Room			0.8	mA
Negative Supply Current	I_-		Room	-3			
Logic Supply Current	I_L		Room			3.2	
Reference Supply Current	I_R		Room	-2			

Notes:

- a. Refer to PROCESS OPTION FLOWCHART.
- b. Room = 25°C , Full = as determined by the operating temperature suffix.
- c. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- d. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
- e. Guaranteed by design, not subject to production test.
- f. V_{IN} = input voltage to perform proper function.

DG186/187/188

TEMIC
Semiconductors

Specifications^a for DG187

Parameter	Symbol	Test Conditions Unless Otherwise Specified $V_+ = 15 \text{ V}$, $V_- = -15 \text{ V}$, $V_L = 5 \text{ V}$ $V_R = 0 \text{ V}$, $V_{IN} = 0.8 \text{ or } 2 \text{ V}^f$	Temp ^b	Limits			Unit
				Min ^d	Typ ^c	Max ^d	
Analog Switch							
Analog Signal Range ^e	V_{ANALOG}		Full	-7.5		15	V
Drain-Source On-Resistance	$r_{DS(on)}$	$I_S = -10 \text{ mA}$, $V_D = -7.5 \text{ V}$	Room Full		22	30 60	Ω
Source Off Leakage Current	$I_{S(off)}$	$V_S = \pm 10 \text{ V}$, $V_D = \mp 10 \text{ V}$ $V_+ = 10 \text{ V}$, $V_- = -20 \text{ V}$	Room Hot		0.06	1 100	nA
		$V_S = \pm 7.5 \text{ V}$, $V_D = \mp 7.5 \text{ V}$	Room Hot		0.13	1 100	
Drain Off Leakage Current	$I_{D(off)}$	$V_S = \pm 10 \text{ V}$, $V_D = \mp 10 \text{ V}$ $V_+ = 10 \text{ V}$, $V_- = -20 \text{ V}$	Room Hot		0.04	1 100	
		$V_S = \pm 7.5 \text{ V}$, $V_D = \mp 7.5 \text{ V}$	Room Hot		0.03	1 100	
Channel On Leakage Current	$I_{D(on)}$	$V_D = V_S = \pm 7.5 \text{ V}$	Room Hot	-2 -200	-0.02		
Digital Input							
Input Current with Input Voltage High	I_{INH}	$V_{IN} = 5 \text{ V}$	Room Hot		<0.01	10 20	μA
Input Current with Input Voltage Low	I_{INL}	$V_{IN} = 0 \text{ V}$	Full	-250	-30		
Dynamic Characteristics							
Turn-On Time	t_{on}	See Switching Time Test Circuit	Room		85	150	ns
Turn-Off Time	t_{off}		Room		95	130	
Source-Off Capacitance	$C_{S(off)}$	$f = 1 \text{ MHz}$	$V_S = -5 \text{ V}$, $I_D = 0$	Room		9	pF
Drain-Off Capacitance	$C_{D(off)}$		$V_D = -5 \text{ V}$, $I_S = 0$	Room		6	
Channel-On Capacitance	$C_{D(on)}$		$V_D = V_S = 0 \text{ V}$	Room		14	
Off Isolation	OIRR	$f = 1 \text{ MHz}$, $R_L = 75 \Omega$		Room		>50	dB
Power Supplies							
Positive Supply Current	I_+	$V_{IN} = 0 \text{ V}$, or 5 V	Room			0.8	mA
Negative Supply Current	I_-		Room	-3			
Logic Supply Current	I_L		Room			3.2	
Reference Supply Current	I_R		Room	-2			

Notes:

- a. Refer to PROCESS OPTION FLOWCHART.
- b. Room = 25°C , Full = as determined by the operating temperature suffix.
- c. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
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- e. Guaranteed by design, not subject to production test.
- f. V_{IN} = input voltage to perform proper function.

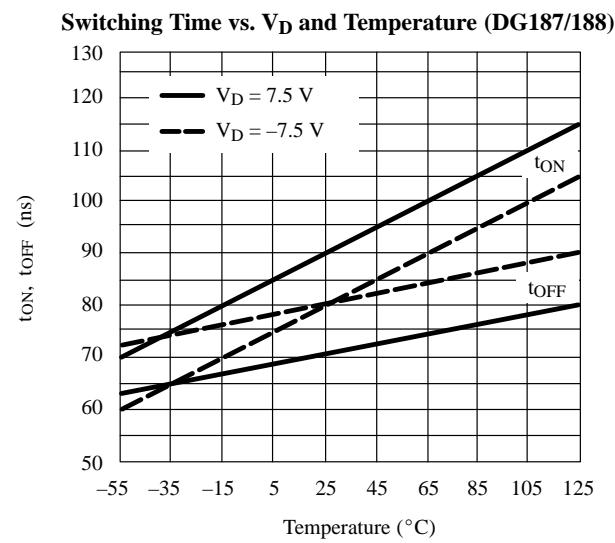
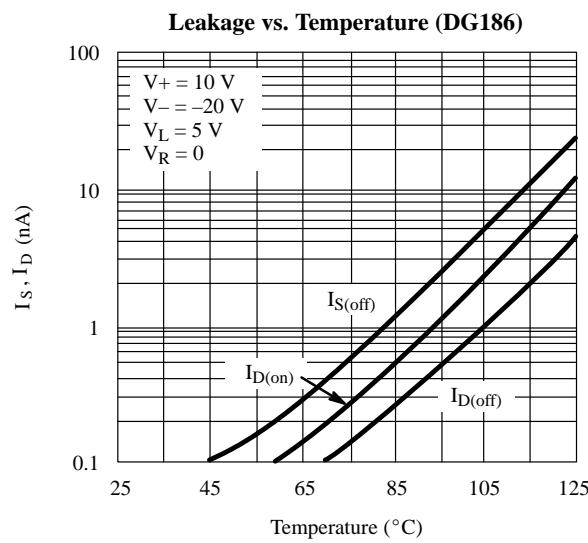
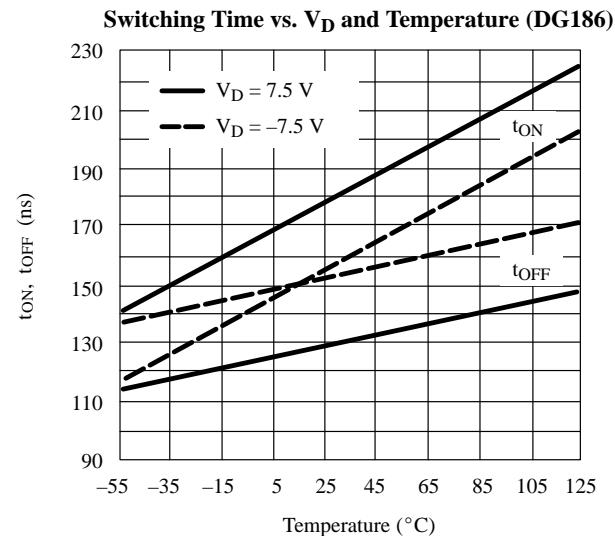
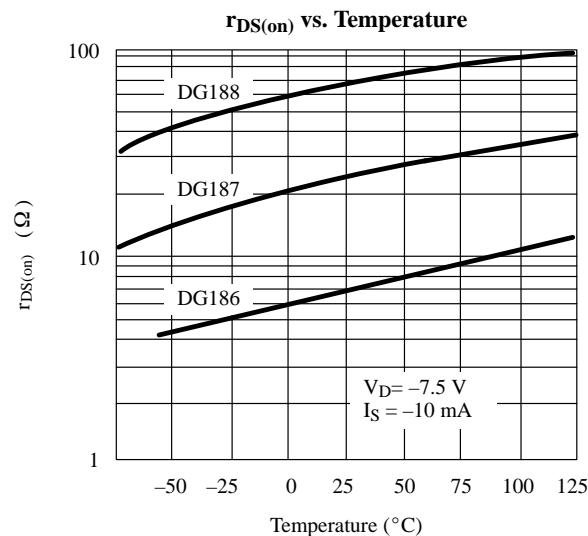
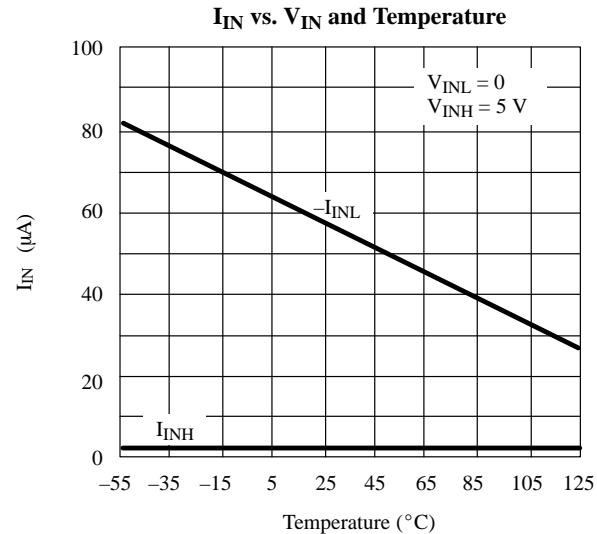
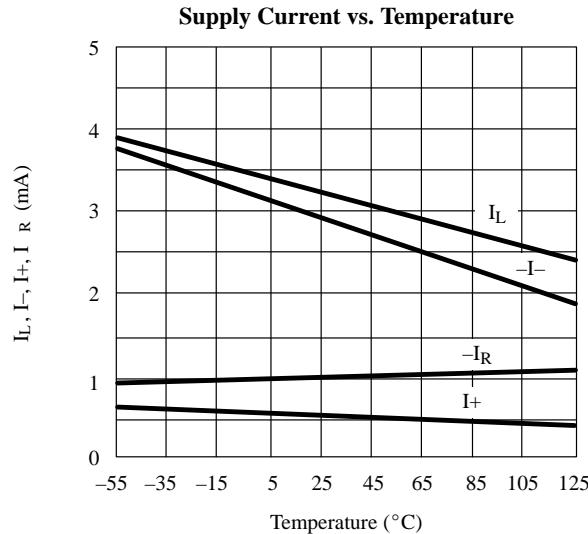
Specifications^a for DG188

Parameter	Symbol	Test Conditions Unless Otherwise Specified $V_+ = 15 \text{ V}$, $V_- = -15 \text{ V}$, $V_L = 5 \text{ V}$ $V_R = 0 \text{ V}$, $V_{IN} = 0.8 \text{ or } 2 \text{ V}^f$	Temp ^b	Limits			Unit
				Min ^d	Typ ^c	Max ^d	
Analog Switch							
Analog Signal Range ^e	V_{ANALOG}		Full	-10		15	V
Drain-Source On-Resistance	$r_{DS(on)}$	$I_S = -10 \text{ mA}$, $V_D = -7.5 \text{ V}$	Room Full		35	75 150	Ω
Source Off Leakage Current	$I_{S(off)}$	$V_S = \pm 10 \text{ V}$, $V_D = \mp 10 \text{ V}$ $V_+ = 10 \text{ V}$, $V_- = -20 \text{ V}$	Room Hot		0.05	1 100	nA
		$V_S = \pm 10 \text{ V}$, $V_D = \mp 10 \text{ V}$	Room Hot		0.07	1 100	
Drain Off Leakage Current	$I_{D(off)}$	$V_S = \pm 10 \text{ V}$, $V_D = \mp 10 \text{ V}$ $V_+ = 10 \text{ V}$, $V_- = -20 \text{ V}$	Room Hot		0.04	1 100	
		$V_S = \pm 10 \text{ V}$, $V_D = \mp 10 \text{ V}$	Room Hot		0.50	1 100	
Channel On Leakage Current	$I_{D(on)}$	$V_D = V_S = \pm 10 \text{ V}$	Room Hot	-2 -200	-0.03		
Digital Input							
Input Current with Input Voltage High	I_{INH}	$V_{IN} = 5 \text{ V}$	Room Hot		<0.01	10 20	μA
Input Current with Input Voltage Low	I_{INL}	$V_{IN} = 0 \text{ V}$	Full	-250	-30		
Dynamic Characteristics							
Turn-On Time	t_{on}	See Switching Time Test Circuit	Room		120	250	ns
Turn-Off Time	t_{off}		Room		100	130	
Source-Off Capacitance	$C_{S(off)}$	$f = 1 \text{ MHz}$	$V_S = -5 \text{ V}$, $I_D = 0$	Room		9	pF
Drain-Off Capacitance	$C_{D(off)}$		$V_D = -5 \text{ V}$, $I_S = 0$	Room		6	
Channel-On Capacitance	$C_{D(on)}$		$V_D = V_S = 0 \text{ V}$	Room		14	
Off Isolation	OIRR	$f = 1 \text{ MHz}$, $R_L = 75 \Omega$		Room		>50	dB
Power Supplies							
Positive Supply Current	I_+	$V_{IN} = 0 \text{ V}$, or 5 V	Room			0.8	mA
Negative Supply Current	I_-		Room	-3			
Logic Supply Current	I_L		Room			3.2	
Reference Supply Current	I_R		Room	-2			

Notes:

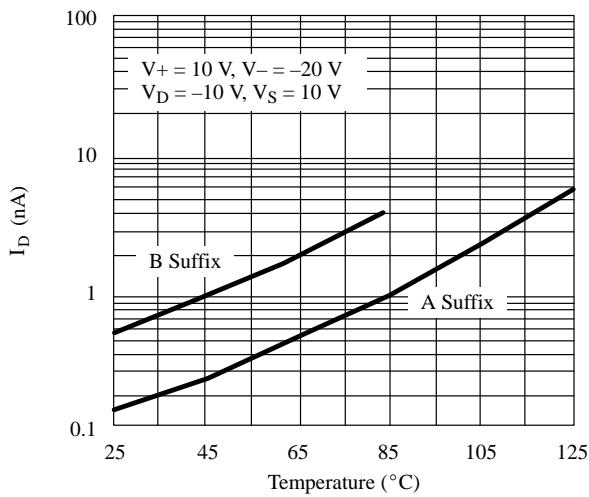
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Typical Characteristics

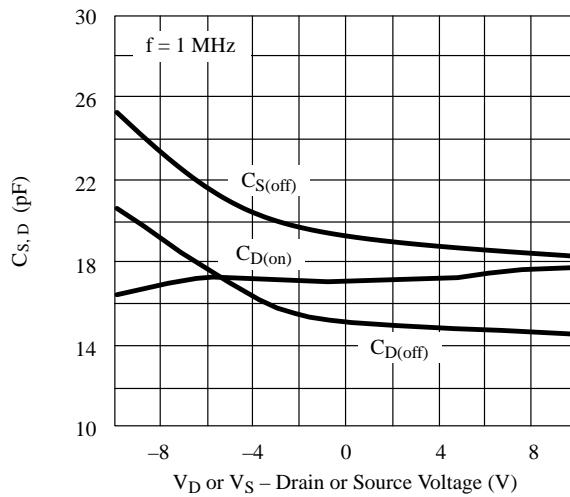


Typical Characteristics (Cont'd)

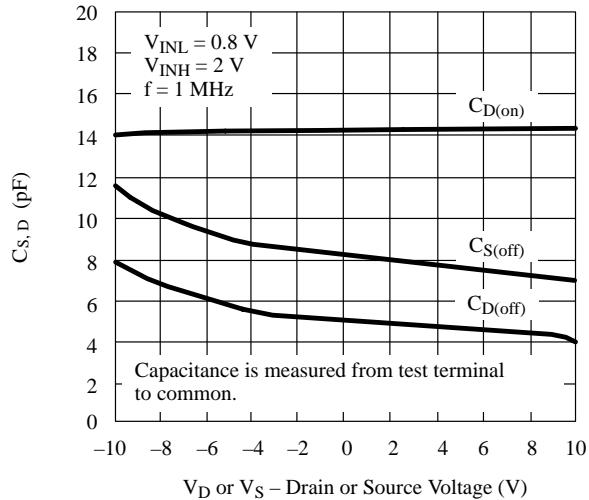
$I_{D(\text{off})}$ vs. Temperature (DG187/188)



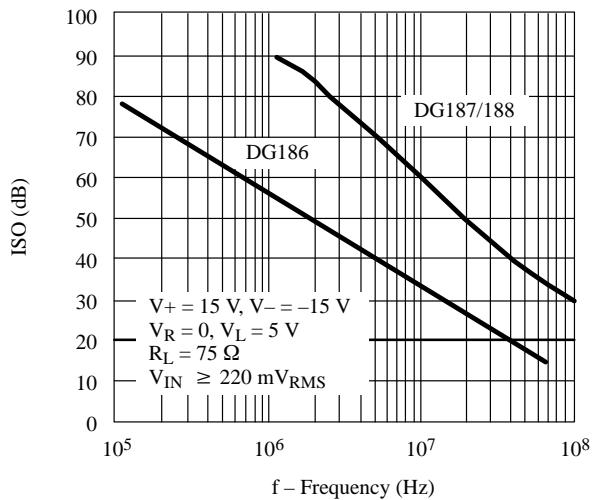
Capacitance vs. V_D or V_S (DG186)



Capacitance vs. V_D or V_S (DG187/188)



Off Isolation vs. Frequency



Test Circuits

Feedthrough due to charge injection may result in spikes at the leading and trailing edge of the output waveform.

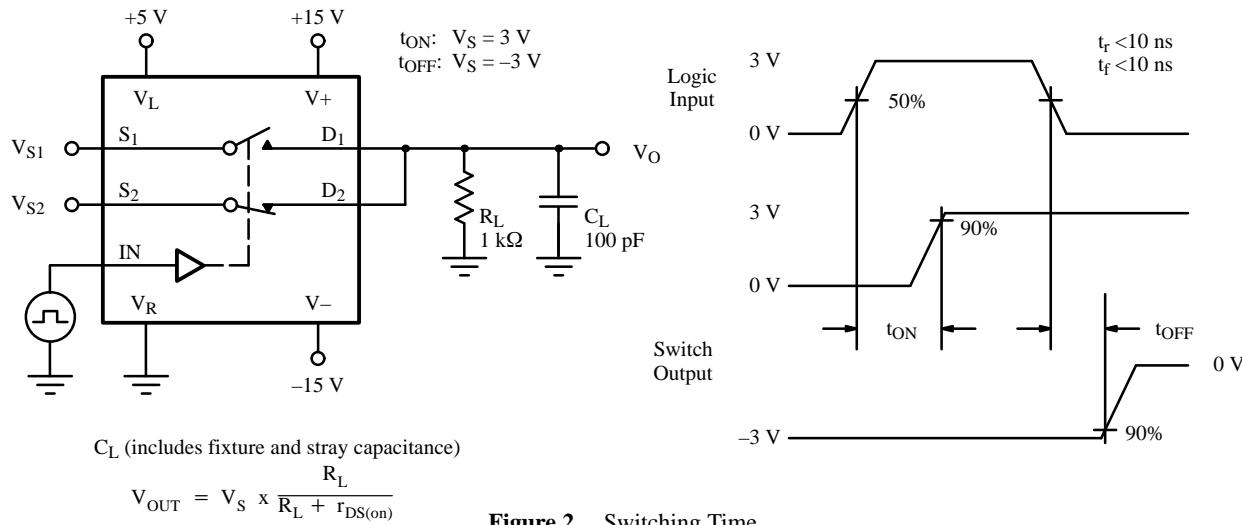


Figure 2. Switching Time

Application Hints^a

Switch	V ₊ Positive Supply Voltage (V)	V ₋ Negative Supply Voltage (V)	V _L Logic Supply Voltage (V)	V _R Reference Supply Voltage (V)	V _{IN} Logic Input Voltage V _{INH(min)/V_{INL(max)}} (V)	V _S Analog Voltage Range (V)
DG186 DG187	15 ^b	-15	5	GND	2.0/0.8	-7.5 to 15
	10	-20	5	GND	2.0/0.8	-12.5 to 10
	12	-12	5	GND	2.0/0.8	-4.5 to 12
DG188	15 ^b	-15	5	GND	2.0/0.8	-10 to 15
	10	-20	5	GND	2.0/0.8	-15 to 10
	12	-12	5	GND	2.0/0.8	-7 to 12

Notes:

- a. Application Hints are for DESIGN AID ONLY, not guaranteed and not subject to production testing.
- b. Electrical Parameter Chart based on V₊ = 15 V, V_L = 5 V, V_R = GND